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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	e200z2, e200z4
Core Size	32-Bit Dual-Core
Speed	80MHz, 160MHz
Connectivity	CANbus, Ethernet, FlexRay, I ² C, LINbus, SPI
Peripherals	DMA, I ² S, POR, WDT
Number of I/O	-
Program Memory Size	2MB (2M x 8)
Program Memory Type	FLASH
EEPROM Size	64K x 8
RAM Size	256K x 8
Voltage - Supply (Vcc/Vdd)	3.15V ~ 5.5V
Data Converters	A/D 36x10b, 16x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LFBGA
Supplier Device Package	100-MAPBGA (11x11)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/spc5745cbk1avmh6

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1 Block diagram

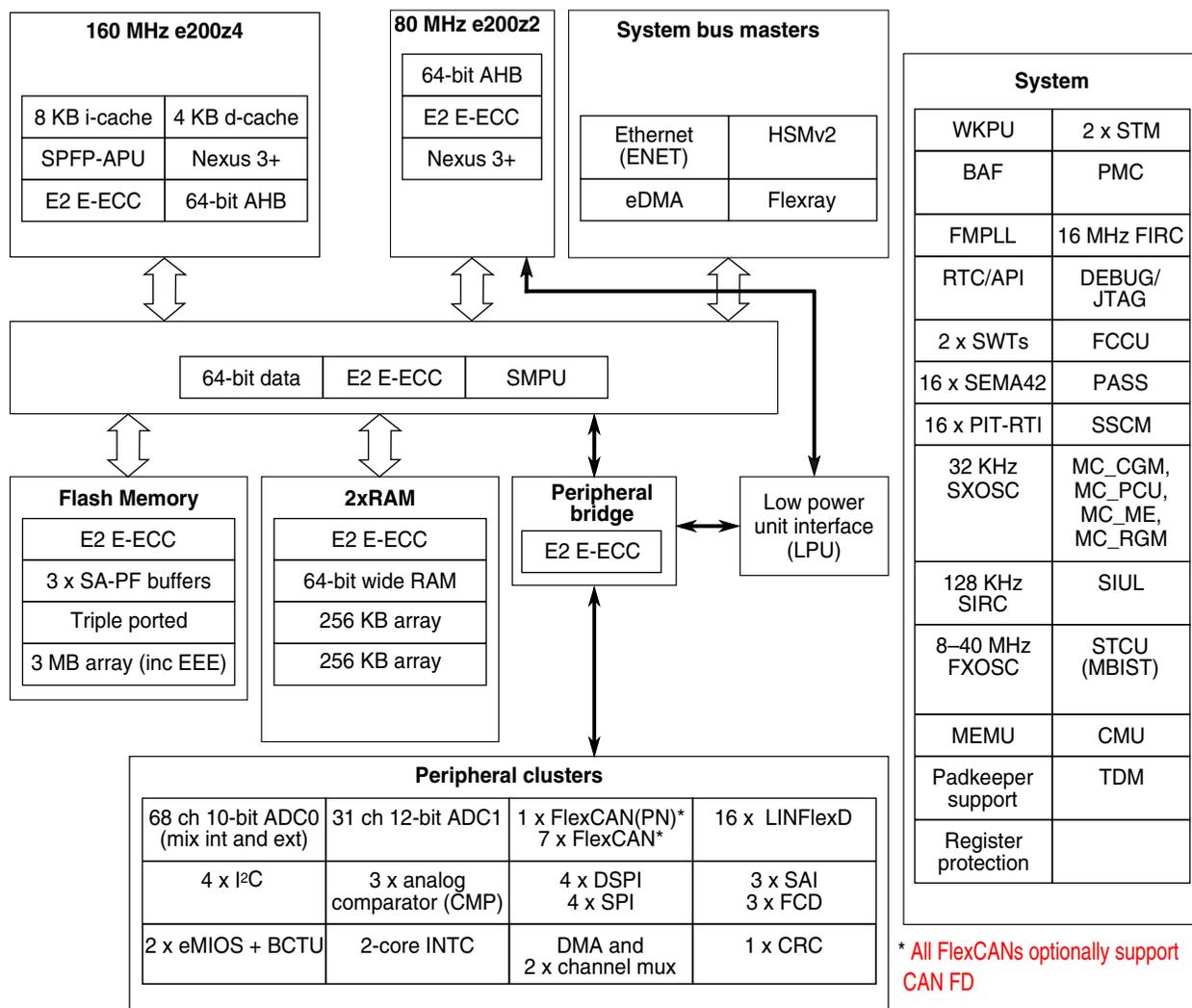


Figure 1. MPC5746C block diagram

2 Family comparison

The following table provides a summary of the different members of the MPC5746C family and their proposed features. This information is intended to provide an understanding of the range of functionality offered by this family. For full details of all of the family derivatives please contact your marketing representative.

NOTE

All optional features (Flash memory, RAM, Peripherals) start with lowest number or address (e.g., FlexCAN0) and end at highest available number or address (e.g., MPC574xB/C have 6 CAN, ending with FlexCAN5).

Table 1. MPC5746C Family Comparison¹

Feature	MPC5745B	MPC5744B	MPC5746B	MPC5744C	MPC5745C	MPC5746C
CPUs	e200z4	e200z4	e200z4	e200z4 e200z2	e200z4 e200z2	e200z4 e200z2
FPU	e200z4	e200z4	e200z4	e200z4	e200z4	e200z4
Maximum Operating Frequency ²	160MHz (Z4)	160MHz (Z4)	160MHz (Z4)	160MHz (Z4) 80MHz (Z2)	160MHz (Z4) 80MHz (Z2)	160MHz (Z4) 80MHz (Z2)
Flash memory	2 MB	1.5 MB	3 MB	1.5 MB	2 MB	3 MB
EEPROM support	Emulated up to 64K			Emulated up to 64K		
RAM	256 KB	192 KB	384 KB (Optional 512KB) ^{3, 3}	192 KB	256 KB	384 KB (Optional 512KB) ³
ECC	End to End					
SMPU	16 entry					
DMA	32 channels					
10-bit ADC	36 Standard channels 32 External channels					
12-bit ADC	15 Precision channels 16 Standard channels					
Analog Comparator	3					
BCTU	1					
SWT	1, SWT[0] ⁴			2 ⁴		
STM	1, STM[0]			2		
PIT-RTI	16 channels PIT 1 channels RTI					
RTC/API	1					
Total Timer I/O ⁵	64 channels 16-bits					
LINFlexD	1 Master and Slave (LINFlexD[0], 11 Master (LINFlexD[1:11]))			1 Master and Slave (LINFlexD[0], 15 Master (LINFlexD[1:15]))		
FlexCAN	6 with optional CAN FD support (FlexCAN[0:5])			8 with optional CAN FD support (FlexCAN[0:7])		
DSPI/SPI	4 x DSPI 4 x SPI					

Table continues on the next page...

3.2 Ordering Information

Example Code	P	PC	57	4	6	C	S	K0	M	MJ	6	R
Qualification Status	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Power Architecture	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Automotive Platform	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Core Version	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Flash Size (core dependent)	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Product	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Optional fields	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Fab and mask indicator	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Temperature spec.	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Package Code	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
CPU Frequency	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
R = Tape & Reel (blank if Tray)												

Qualification Status P = Engineering samples S = Automotive qualified PC = Power Architecture Automotive Platform 57 = Power Architecture in 55nm Core Version 4 = e200z4 Core Version (highest core version in the case of multiple cores) Flash Memory Size 4 = 1.5 MB 5 = 2 MB 6 = 3 MB	Product Version B = Single core C = Dual core Optional fields Blank = No optional feature S = HSM (Security Module) F = CAN FD B = HSM + CAN FD R = 512K RAM T = HSM + 512K RAM G* = CAN FD + 512K RAM H* = HSM + CAN FD + 512K RAM * G and H for 5746 B/C only	Fab and mask version indicator K = TSMC Fab #(0,1,etc.) = Version of the maskset, like rev. 0=0N65H Temperature spec. C = -40.C to +85.C Ta V = -40.C to +105.C Ta M = -40.C to +125.C Ta	Package Code KU = 176 LQFP EP MJ = 256 MAPBGA MN = 324 MAPBGA MH = 100MAPBGA CPU Frequency 2 = Z4 operates upto 120 MHz 6 = Z4 operates upto 160 MHz Shipping Method R = Tape and reel Blank = Tray
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Note: Not all part number combinations are available as production product

4 General

4.1 Absolute maximum ratings

NOTE

Functional operating conditions appear in the DC electrical characteristics. Absolute maximum ratings are stress ratings only, and functional operation at the maximum values is not guaranteed. See footnotes in [Table 5](#) for specific conditions

Stress beyond the listed maximum values may affect device reliability or cause permanent damage to the device.

Table 5. Absolute maximum ratings

Symbol	Parameter	Conditions ¹	Min	Max	Unit
$V_{DD_HV_A}$, $V_{DD_HV_B}$, $V_{DD_HV_C}$ ^{2,3}	3.3 V - 5.5V input/output supply voltage	—	-0.3	6.0	V
$V_{DD_HV_FLA}$ ^{4,5}	3.3 V flash supply voltage (when supplying from an external source in bypass mode)	—	-0.3	3.63	V
$V_{DD_LP_DEC}$ ⁶	Decoupling pin for low power regulators ⁷	—	-0.3	1.32	V
$V_{DD_HV_ADC1_REF}$ ⁸	3.3 V / 5.0 V ADC1 high reference voltage	—	-0.3	6	V
$V_{DD_HV_ADC0}$ $V_{DD_HV_ADC1}$	3.3 V to 5.5V ADC supply voltage	—	-0.3	6.0	V
$V_{SS_HV_ADC0}$ $V_{SS_HV_ADC1}$	3.3V to 5.5V ADC supply ground	—	-0.1	0.1	V
V_{DD_LV} ^{9, 10, 10, 11, 11, 12}	Core logic supply voltage	—	-0.3	1.32	V
V_{INA}	Voltage on analog pin with respect to ground (V_{SS_HV})	—	-0.3	Min ($V_{DD_HV_x}$, $V_{DD_HV_ADCx}$, $V_{DD_ADCx_REF}$) +0.3	V
V_{IN}	Voltage on any digital pin with respect to ground (V_{SS_HV})	Relative to $V_{DD_HV_A}$, $V_{DD_HV_B}$, $V_{DD_HV_C}$	-0.3	$V_{DD_HV_x} + 0.3$	V
I_{INJPAD}	Injected input current on any pin during overload condition	Always	-5	5	mA
I_{INJSUM}	Absolute sum of all injected input currents during overload condition	—	-50	50	mA
T_{ramp}	Supply ramp rate	—	0.5 V / min	100V/ms	—
T_A ¹³	Ambient temperature	—	-40	125	°C
T_{STG}	Storage temperature	—	-55	165	°C

- All voltages are referred to V_{SS_HV} unless otherwise specified
- $V_{DD_HV_B}$ and $V_{DD_HV_C}$ are common together on the 176 LQFP-EP package.
- Allowed $V_{DD_HV_x} = 5.5\text{--}6.0$ V for 60 seconds cumulative time with no restrictions, for 10 hours cumulative time device in reset, $T_J = 150$ °C, remaining time at or below 5.5 V.
- $V_{DD_HV_FLA}$ must be connected to $V_{DD_HV_A}$ when $V_{DD_HV_A} = 3.3$ V
- $V_{DD_HV_FLA}$ must be disconnected from ANY power sources when $V_{DD_HV_A} = 5$ V
- This pin should be decoupled with low ESR 1 μ F capacitor.
- Not available for input voltage, only for decoupling internal regulators
- 10-bit ADC does not have dedicated reference and its reference is bonded to 10-bit ADC supply ($V_{DD_HV_ADC0}$) inside the package.
- Allowed 1.45 – 1.5 V for 60 seconds cumulative time at maximum $T_J = 150$ °C, remaining time as defined in footnotes 10 and 11.
- Allowed 1.38 – 1.45 V – for 10 hours cumulative time at maximum $T_J = 150$ °C, remaining time as defined in footnote 11.
- 1.32 – 1.38 V range allowed periodically for supply with sinusoidal shape and average supply value below 1.326 V at maximum $T_J = 150$ °C.
- If HVD on core supply ($V_{HVD_LV_x}$) is enabled, it will generate a reset when supply goes above threshold.
- $T_J = 150$ °C. Assumes $T_A = 125$ °C
 - Assumes maximum θ_{JA} for 2s2p board. See [Thermal attributes](#)

4. VDD_LV supply pins should never be grounded (through a small impedance). If these are not driven, they should only be left floating
5. $V_{IN1_CMP_REF} \leq V_{DD_HV_A}$
6. This supply is shorted VDD_HV_A on lower packages.
7. $T_J=150^{\circ}\text{C}$. Assumes $T_A=125^{\circ}\text{C}$
 - Assumes maximum θ_{JA} of 2s2p board. See [Thermal attributes](#)

4.3 Voltage regulator electrical characteristics

The voltage regulator is composed of the following blocks:

- Choice of generating supply voltage for the core area.
 - Control of external NPN ballast transistor
 - Generating core supply using internal ballast transistor
 - Connecting an external 1.25 V (nominal) supply directly without the NPN ballast
- Internal generation of the 3.3 V flash supply when device connected in 5V applications
- External bypass of the 3.3 V flash regulator when device connected in 3.3V applications
- Low voltage detector - low threshold (LVD_IO_A_LO) for $V_{DD_HV_IO_A}$ supply
- Low voltage detector - high threshold (LVD_IO_A_Hi) for $V_{DD_HV_IO_A}$ supply
- Low voltage detector (LVD_FLASH) for 3.3 V flash supply ($V_{DD_HV_FLA}$)
- Various low voltage detectors (LVD_LV_x)
- High voltage detector (HVD_LV_cold) for 1.2 V digital core supply (VDD_LV)
- Power on Reset (POR_LV) for 1.25 V digital core supply (VDD_LV)
- Power on Reset (POR_HV) for 3.3 V to 5 V supply (VDD_HV_A)

The following bipolar transistors¹ are supported, depending on the device performance requirements. As a minimum the following must be considered when determining the most appropriate solution to maintain the device under its maximum power dissipation capability: current, ambient temperature, mounting pad area, duty cycle and frequency for I_{dd} , collector voltage, etc

1. BCP56, MCP68 and MJD31 are guaranteed ballasts.

4.4 Voltage monitor electrical characteristics

Table 9. Voltage monitor electrical characteristics

Symbol	Parameter	State	Conditions	Configuration			Threshold			Unit
				Power Up ¹	Mask Opt ^{2,2}	Reset Type	Min	Typ	Max	V
V _{POR_LV}	LV supply power on reset detector	Fall	Untrimmed	Yes	No	Destructive	0.930	0.979	1.028	V
			Trimmed				-	-	-	V
		Rise	Untrimmed				0.980	1.029	1.078	V
			Trimmed				-	-	-	V
V _{HVD_LV_col d}	LV supply high voltage monitoring, detecting at device pin	Fall	Untrimmed	No	Yes	Functional	Disabled at Start			
			Trimmed				1.325	1.345	1.375	V
		Rise	Untrimmed				Disabled at Start			
			Trimmed				1.345	1.365	1.395	V
V _{LVD_LV_PD2_hot}	LV supply low voltage monitoring, detecting on the PD2 core (hot) area	Fall	Untrimmed	Yes	No	Destructive	1.0800	1.1200	1.1600	V
			Trimmed				1.1250	1.1425	1.1600	V
		Rise	Untrimmed				1.1000	1.1400	1.1800	V
			Trimmed				1.1450	1.1625	1.1800	V
V _{LVD_LV_PD1_hot (BGFP)}	LV supply low voltage monitoring, detecting on the PD1 core (hot) area	Fall	Untrimmed	Yes	No	Destructive	1.0800	1.1200	1.1600	V
			Trimmed				1.1140	1.1370	1.1600	V
		Rise	Untrimmed				1.1000	1.140	1.1800	V
			Trimmed				1.1340	1.1570	1.1800	V
V _{LVD_LV_PD0_hot (BGFP)}	LV supply low voltage monitoring, detecting on the PD0 core (hot) area	Fall	Untrimmed	Yes	No	Destructive	1.0800	1.1200	1.1600	V
			Trimmed				1.1140	1.1370	1.1600	V
		Rise	Untrimmed				1.1000	1.1400	1.1800	V
			Trimmed				1.1340	1.1570	1.1800	V
V _{POR_HV}	HV supply power on reset detector	Fall	Untrimmed	Yes	No	Destructive	2.7000	2.8500	3.0000	V
			Trimmed				-	-	-	V
		Rise	Untrimmed				2.7500	2.9000	3.0500	V
			Trimmed				-	-	-	V
V _{LVD_IO_A_L O^{3,3}}	HV IO_A supply low voltage monitoring - low range	Fall	Untrimmed	Yes	No	Destructive	2.7500	2.9230	3.0950	V
			Trimmed				2.9780	3.0390	3.1000	V
		Rise	Untrimmed				2.7800	2.9530	3.1250	V
			Trimmed				3.0080	3.0690	3.1300	V
V _{LVD_IO_A_H I³}	HV IO_A supply low voltage monitoring - high range	Fall	Trimmed	No	Yes	Destructive	Disabled at Start			
							4.0600	4.151	4.2400	V
		Rise	Trimmed				Disabled at Start			
							4.1150	4.2010	4.3000	V

Table continues on the next page...

Table 9. Voltage monitor electrical characteristics (continued)

Symbol	Parameter	State	Conditions	Configuration			Threshold			Unit
				Power Up ¹	Mask Opt ^{2,2}	Reset Type	Min	Typ	Max	V
V _{LVD_LV_PD} 2_cold	LV supply low voltage monitoring, detecting at the device pin	Fall	Untrimmed	No	Yes	Function al	Disabled at Start			
			Trimmed				1.1400	1.1550	1.1750	V
		Rise	Untrimmed	Disabled at Start						
			Trimmed	1.1600	1.1750	1.1950	V			

1. All monitors that are active at power-up will gate the power up recovery and prevent exit from POWERUP phase until the minimum level is crossed. These monitors can in some cases be masked during normal device operation, but when active will always generate a destructive reset.
2. Voltage monitors marked as non maskable are essential for device operation and hence cannot be masked.
3. There is no voltage monitoring on the V_{DD_HV_ADC0}, V_{DD_HV_ADC1}, V_{DD_HV_B} and V_{DD_HV_C} I/O segments. For applications requiring monitoring of these segments, either connect these to V_{DD_HV_A} at the PCB level or monitor externally.

4.5 Supply current characteristics

Current consumption data is given in the following table. These specifications are design targets and are subject to change per device characterization.

NOTE

The ballast must be chosen in accordance with the ballast transistor supplier operating conditions and recommendations.

Table 10. Current consumption characteristics

Symbol	Parameter	Conditions ¹	Min	Typ	Max	Unit
I _{DD_BODY_1} 2, 3	RUN Body Mode Profile Operating current	LV supply + HV supply + HV Flash supply + 2 x HV ADC supplies ^{4,4} T _a = 125°C ^{5,5} V _{DD_LV} = 1.25 V V _{DD_HV_A} = 5.5V SYS_CLK = 80MHz	—	—	147	mA
		T _a = 105°C	—	—	142	mA
		T _a = 85 °C	—	—	137	mA

Table continues on the next page...

Table 10. Current consumption characteristics (continued)

Symbol	Parameter	Conditions ¹	Min	Typ	Max	Unit
$I_{DD_HV_ADC_REF}$ ^{10, 11, 11}	ADC REF Operating current	$T_a = 125\text{ }^\circ\text{C}$ ⁵ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 5.5\text{ V}$	—	200	400	μA
		$T_a = 105\text{ }^\circ\text{C}$ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 5.5\text{ V}$	—	200	—	
		$T_a = 85\text{ }^\circ\text{C}$ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 5.5\text{ V}$	—	200	—	
		$T_a = 25\text{ }^\circ\text{C}$ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 3.6\text{ V}$	—	200	—	
$I_{DD_HV_ADCx}$ ¹¹	ADC HV Operating current	$T_a = 125\text{ }^\circ\text{C}$ ⁵ ADC operating at 80 MHz $V_{DD_HV_ADC} = 5.5\text{ V}$	—	1.2	2	mA
		$T_a = 25\text{ }^\circ\text{C}$ ADC operating at 80 MHz $V_{DD_HV_ADC} = 3.6\text{ V}$	—	1	2	
$I_{DD_HV_FLASH}$ ¹²	Flash Operating current during read access	$T_a = 125\text{ }^\circ\text{C}$ ⁵ 3.3 V supplies 160 MHz frequency	—	40	45	mA
		$T_a = 105\text{ }^\circ\text{C}$ 3.3 V supplies 160 MHz frequency	—	40	45	
		$T_a = 85\text{ }^\circ\text{C}$ 3.3 V supplies 160 MHz frequency	—	40	45	

- The content of the Conditions column identifies the components that draw the specific current.
- Single e200Z4 core cache disabled @80 MHz, no FlexRay, no ENET, 2 x CAN, 8 LINFlexD, 2 SPI, ADC0 and 1 used constantly, no HSM, Memory: 2M flash, 128K RAM RUN mode, Clocks: FIRC on, XOSC, PLL on, SIRC on for TOD, no 32KHz crystal (TOD runs off SIRC).
- Recommended Transistors:MJD31 @ 85°C, 105°C and 125°C. In case of internal ballast mode, it is expected that the external ballast is not mounted and BAL_SELECT_INT pin is tied to VDD_HV_A supply on board. Internal ballast can be used for all use cases with current consumption upto 150mA
- The power consumption does not consider the dynamic current of I/Os
- $T_j=150^\circ\text{C}$. Assumes $T_a=125^\circ\text{C}$
 - Assumes maximum θ_{JA} of 2s2p board. See [Thermal attributes](#)
- e200Z4 core, 160MHz, cache enabled; e200Z2 core , 80MHz, no FlexRay, no ENET, 7 CAN, 16 LINFlexD, 4 SPI, 1x ADC used constantly, includes HSM at start-up / periodic use, Memory: 3M flash, 256K RAM, Clocks: FIRC on, XOSC on, PLL on, SIRC on, no 32KHz crystal
- e200Z4 core, 120MHz, cache enabled; e200Z2 core, 60MHz; no FlexRay, no ENET, 7 CAN, 16 LINFlexD, 4 SPI, 1x ADC used constantly, includes HSM at start-up / periodic use, Memory: 3M flash, 128K RAM, Clocks: FIRC on, XOSC on, PLL on, SIRC on, no 32KHz crystal

5.2 DC electrical specifications @ 3.3V Range

Table 15. DC electrical specifications @ 3.3V Range

Symbol	Parameter	Value		Unit
		Min	Max	
Vih (pad_i_hv)	Pad_I_HV Input Buffer High Voltage	$0.72 \cdot VDD_HV_x$	$VDD_HV_x + 0.3$	V
Vil (pad_i_hv)	Pad_I_HV Input Buffer Low Voltage	$VDD_HV_x - 0.3$	$0.45 \cdot VDD_HV_x$	V
Vhys (pad_i_hv)	Pad_I_HV Input Buffer Hysteresis	$0.11 \cdot VDD_HV_x$		V
Vih_hys	CMOS Input Buffer High Voltage (with hysteresis enabled)	$0.67 \cdot VDD_HV_x$	$VDD_HV_x + 0.3$	V
Vil_hys	CMOS Input Buffer Low Voltage (with hysteresis enabled)	$VDD_HV_x - 0.3$	$0.35 \cdot VDD_HV_x$	V
Vih	CMOS Input Buffer High Voltage (with hysteresis disabled)	$0.57 \cdot VDD_HV_x^{1,1}$	$VDD_HV_x^{1,1} + 0.3$	V
Vil	CMOS Input Buffer Low Voltage (with hysteresis disabled)	$VDD_HV_x - 0.3$	$0.4 \cdot VDD_HV_x^{1,1}$	V
Vhys	CMOS Input Buffer Hysteresis	$0.09 \cdot VDD_HV_x^{1,1}$		V
Pull_IH (pad_i_hv)	Weak Pullup Current ^{2,2} Low	15		μA
Pull_IH (pad_i_hv)	Weak Pullup Current ^{3,3} High		55	μA
Pull_IL (pad_i_hv)	Weak Pulldown Current ³ Low	28		μA
Pull_IL (pad_i_hv)	Weak Pulldown Current ² High		85	μA
Pull_loh	Weak Pullup Current ⁴	15	50	μA
Pull_lol	Weak Pulldown Current ⁵	15	50	μA
linact_d	Digital Pad Input Leakage Current (weak pull inactive)	-2.5	2.5	μA
Voh	Output High Voltage ⁶	$0.8 \cdot VDD_HV_x^{1,1}$	—	V
Vol	Output Low Voltage ⁷ Output Low Voltage ⁸	—	$0.2 \cdot VDD_HV_x^{1,1}$ $0.1 \cdot VDD_HV_x$	V
Ioh_f	Full drive Ioh ^{9,9} (SIUL2_MSCRn.SRC[1:0] = 11)	18	70	mA
Iol_f	Full drive Iol ⁹ (SIUL2_MSCRn.SRC[1:0] = 11)	21	120	mA
Ioh_h	Half drive Ioh ⁹ (SIUL2_MSCRn.SRC[1:0] = 10)	9	35	mA
Iol_h	Half drive Iol ⁹ (SIUL2_MSCRn.SRC[1:0] = 10)	10.5	60	mA

1. $VDD_HV_x = VDD_HV_A, VDD_HV_B, VDD_HV_C$
2. Measured when $pad = 0.69 \cdot VDD_HV_x$
3. Measured when $pad = 0.49 \cdot VDD_HV_x$
4. Measured when $pad = 0\text{ V}$
5. Measured when $pad = VDD_HV_x$
6. Measured when pad is sourcing 2 mA
7. Measured when pad is sinking 2 mA
8. Measured when pad is sinking 1.5 mA
9. Ioh/Iol is derived from spice simulations. These values are NOT guaranteed by test.

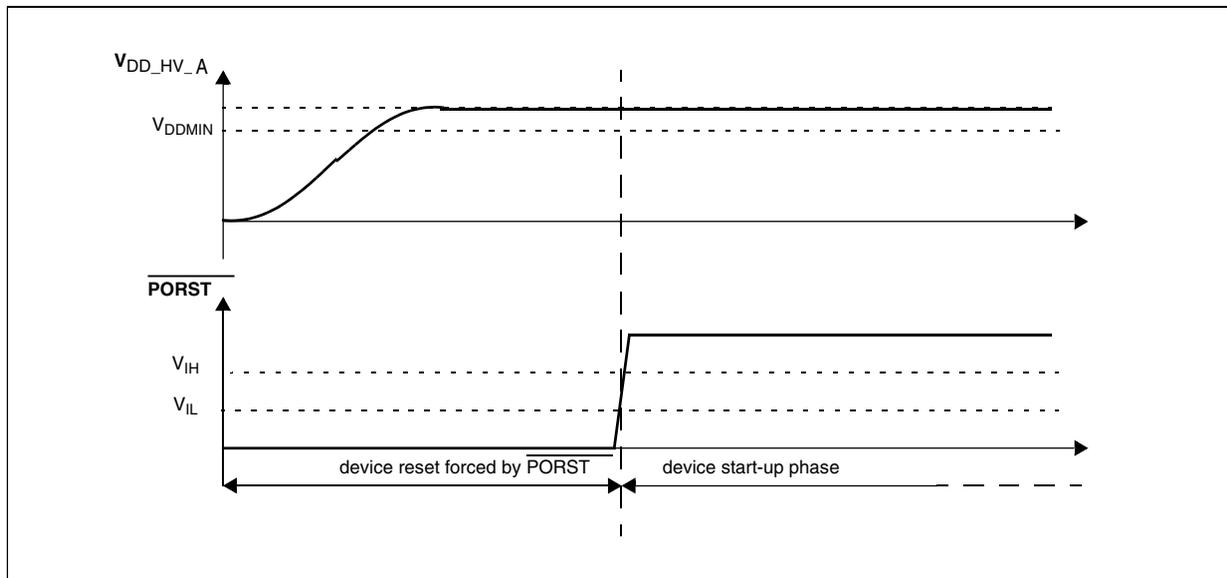


Figure 3. Start-up reset requirements

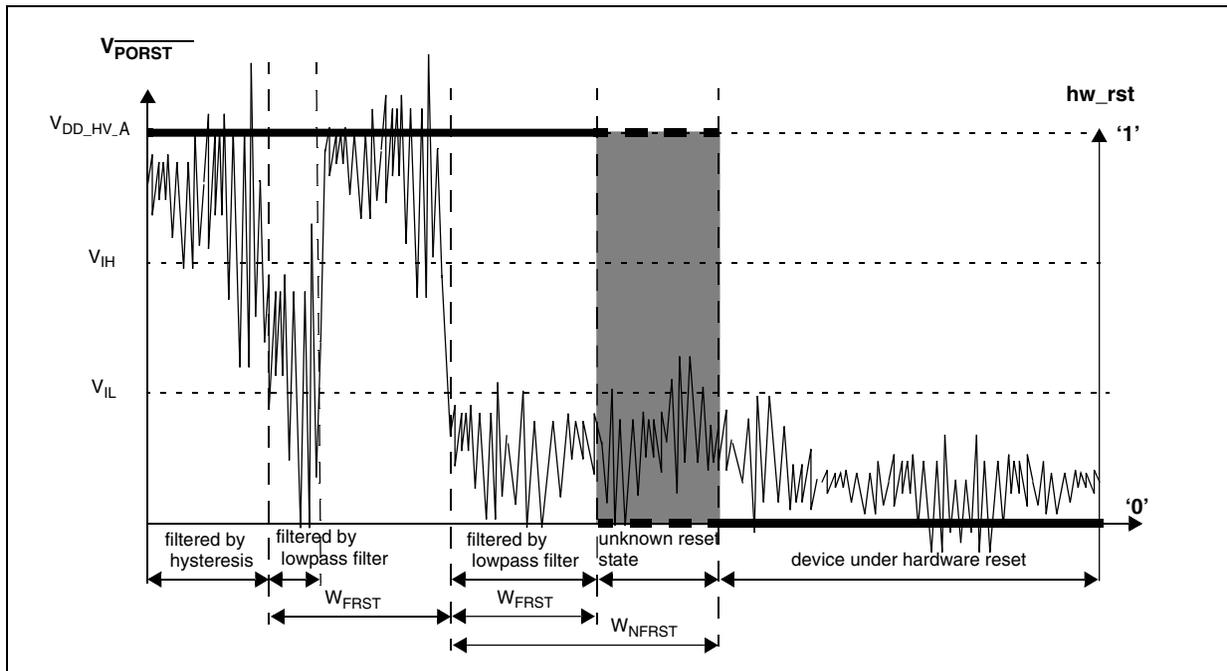


Figure 4. Noise filtering on reset signal

Table 18. Functional reset pad electrical specifications

Symbol	Parameter	Conditions	Value			Unit
			Min	Typ	Max	
V_{IH}	CMOS Input Buffer High Voltage	—	$0.65 \cdot V_{D_{HV_x}}$	—	$V_{D_{HV_x}} + 0.3$	V
V_{IL}	CMOS Input Buffer Low Voltage	—	$V_{D_{HV_x}} - 0.3$	—	$0.35 \cdot V_{D_{HV_x}}$	V

Table continues on the next page...

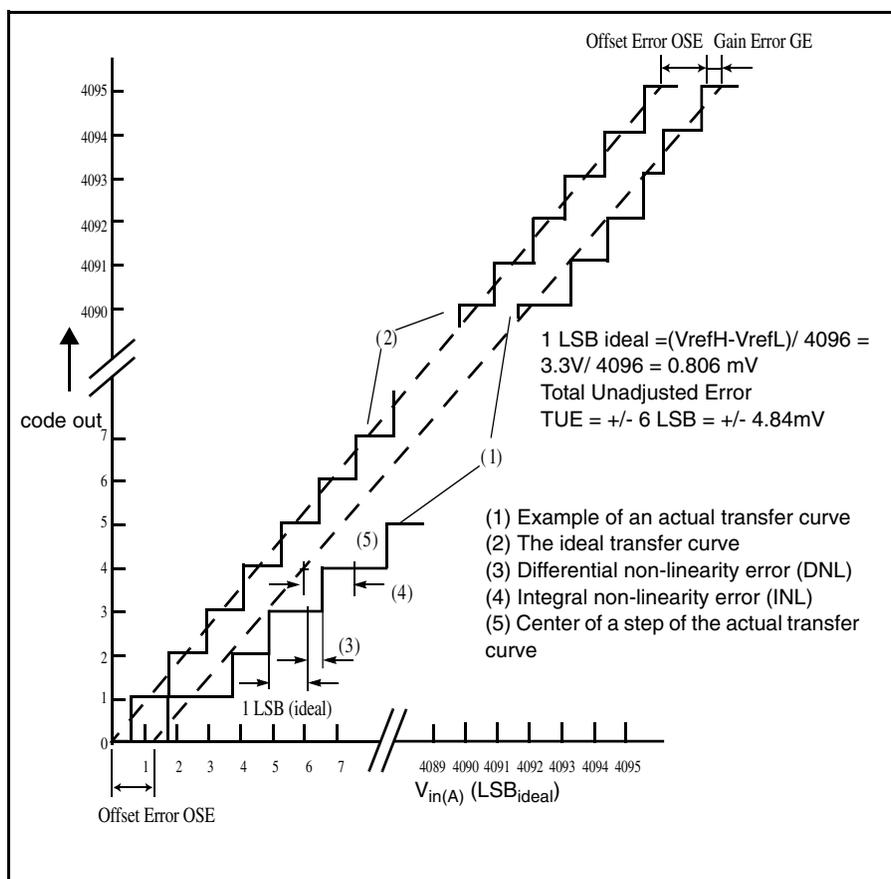
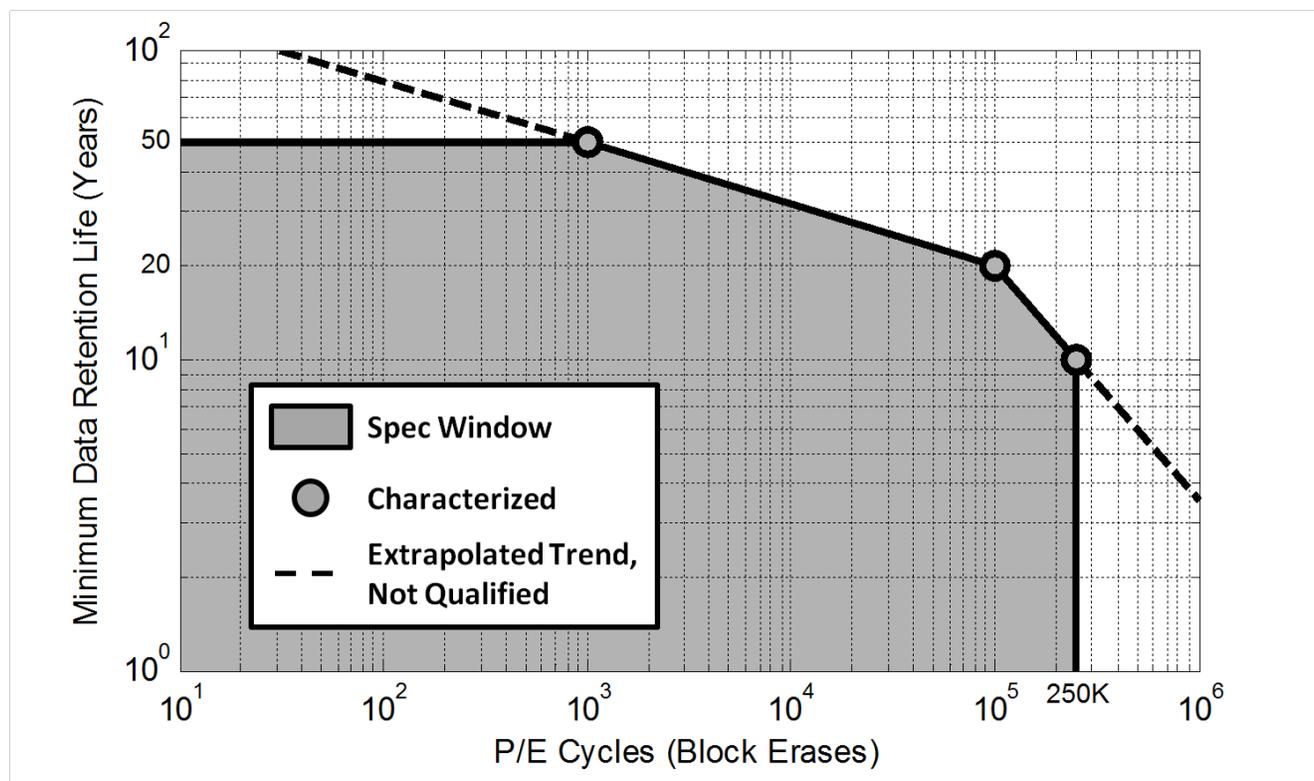


Figure 5. ADC characteristics and error definitions



6.3.5 Flash memory AC timing specifications

Table 33. Flash memory AC timing specifications

Symbol	Characteristic	Min	Typical	Max	Units
t_{psus}	Time from setting the MCR-PSUS bit until MCR-DONE bit is set to a 1.	—	9.4 plus four system clock periods	11.5 plus four system clock periods	μ s
t_{esus}	Time from setting the MCR-ESUS bit until MCR-DONE bit is set to a 1.	—	16 plus four system clock periods	20.8 plus four system clock periods	μ s
t_{res}	Time from clearing the MCR-ESUS or PSUS bit with EHV = 1 until DONE goes low.	—	—	100	ns
t_{done}	Time from 0 to 1 transition on the MCR-EHV bit initiating a program/erase until the MCR-DONE bit is cleared.	—	—	5	ns
t_{dones}	Time from 1 to 0 transition on the MCR-EHV bit aborting a program/erase until the MCR-DONE bit is set to a 1.	—	16 plus four system clock periods	20.8 plus four system clock periods	μ s

Table continues on the next page...

6.4.2 FlexRay electrical specifications

6.4.2.1 FlexRay timing

This section provides the FlexRay Interface timing characteristics for the input and output signals. It should be noted that these are recommended numbers as per the FlexRay EPL v3.0 specification, and subject to change per the final timing analysis of the device.

6.4.2.2 TxEN

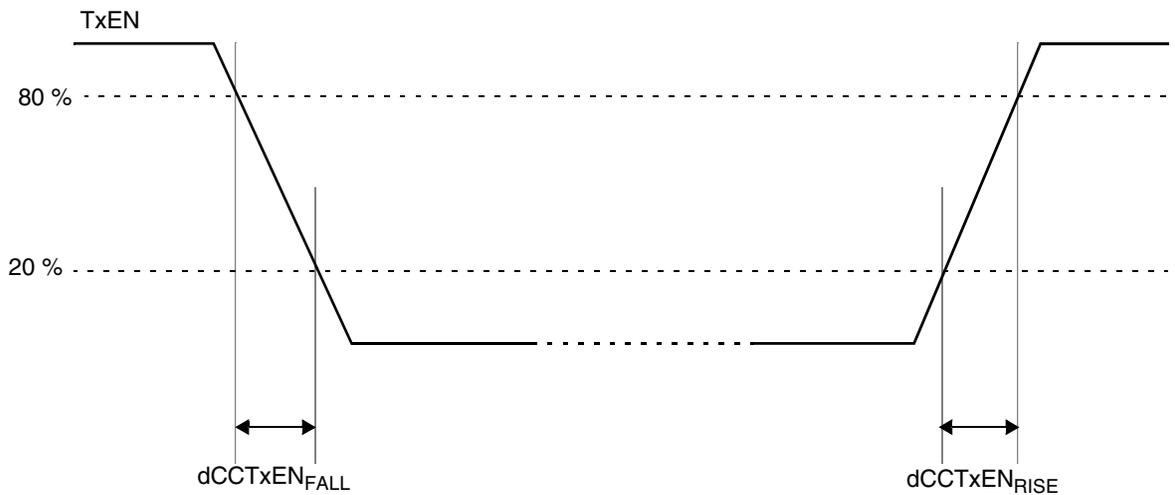


Figure 17. TxEN signal

Table 38. TxEN output characteristics¹

Name	Description	Min	Max	Unit
$dCCTxEN_{RISE25}$	Rise time of TxEN signal at CC	—	9	ns
$dCCTxEN_{FALL25}$	Fall time of TxEN signal at CC	—	9	ns
$dCCTxEN_{01}$	Sum of delay between Clk to Q of the last FF and the final output buffer, rising edge	—	25	ns
$dCCTxEN_{10}$	Sum of delay between Clk to Q of the last FF and the final output buffer, falling edge	—	25	ns

1. All parameters specified for $V_{DD_HV_IOx} = 3.3\text{ V} -5\%$, $\pm 10\%$, $T_J = -40\text{ }^\circ\text{C} / 150\text{ }^\circ\text{C}$, TxEN pin load maximum 25 pF

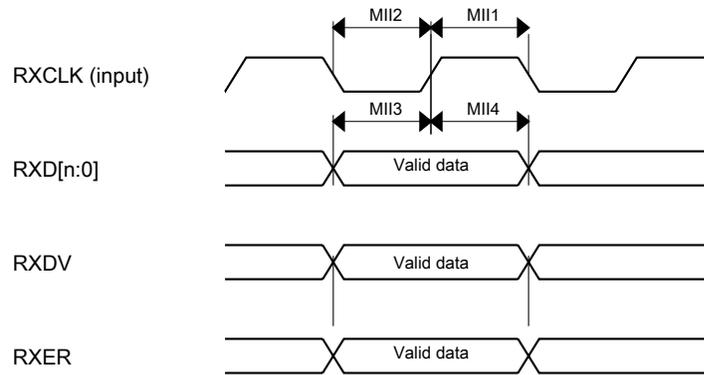


Figure 22. RMII/MII receive signal timing diagram

6.4.3.2 RMII signal switching specifications

The following timing specs meet the requirements for RMII style interfaces for a range of transceiver devices.

Table 42. RMII signal switching specifications

Num	Description	Min.	Max.	Unit
—	EXTAL frequency (RMII input clock RMII_CLK)	—	50	MHz
RMII1	RMII_CLK pulse width high	35%	65%	RMII_CLK period
RMII2	RMII_CLK pulse width low	35%	65%	RMII_CLK period
RMII3	RXD[1:0], CRS_DV, RXER to RMII_CLK setup	4	—	ns
RMII4	RMII_CLK to RXD[1:0], CRS_DV, RXER hold	2	—	ns
RMII7	RMII_CLK to TXD[1:0], TXEN invalid	4	—	ns
RMII8	RMII_CLK to TXD[1:0], TXEN valid	—	15	ns

6.4.4 SAI electrical specifications

All timing requirements are specified relative to the clock period or to the minimum allowed clock period of a device

Table 43. Master mode SAI Timing

no	Parameter	Value		Unit
		Min	Max	
	Operating Voltage	2.7	3.6	V
S1	SAI_MCLK cycle time	40	-	ns

Table continues on the next page...

Table 43. Master mode SAI Timing (continued)

no	Parameter	Value		Unit
		Min	Max	
S2	SAI_MCLK pulse width high/low	45%	55%	MCLK period
S3	SAI_BCLK cycle time	80	-	BCLK period
S4	SAI_BCLK pulse width high/low	45%	55%	ns
S5	SAI_BCLK to SAI_FS output valid	-	15	ns
S6	SAI_BCLK to SAI_FS output invalid	0	-	ns
S7	SAI_BCLK to SAI_TXD valid	-	15	ns
S8	SAI_BCLK to SAI_TXD invalid	0	-	ns
S9	SAI_RXD/SAI_FS input setup before SAI_BCLK	28	-	ns
S10	SAI_RXD/SAI_FS input hold after SAI_BCLK	0	-	ns

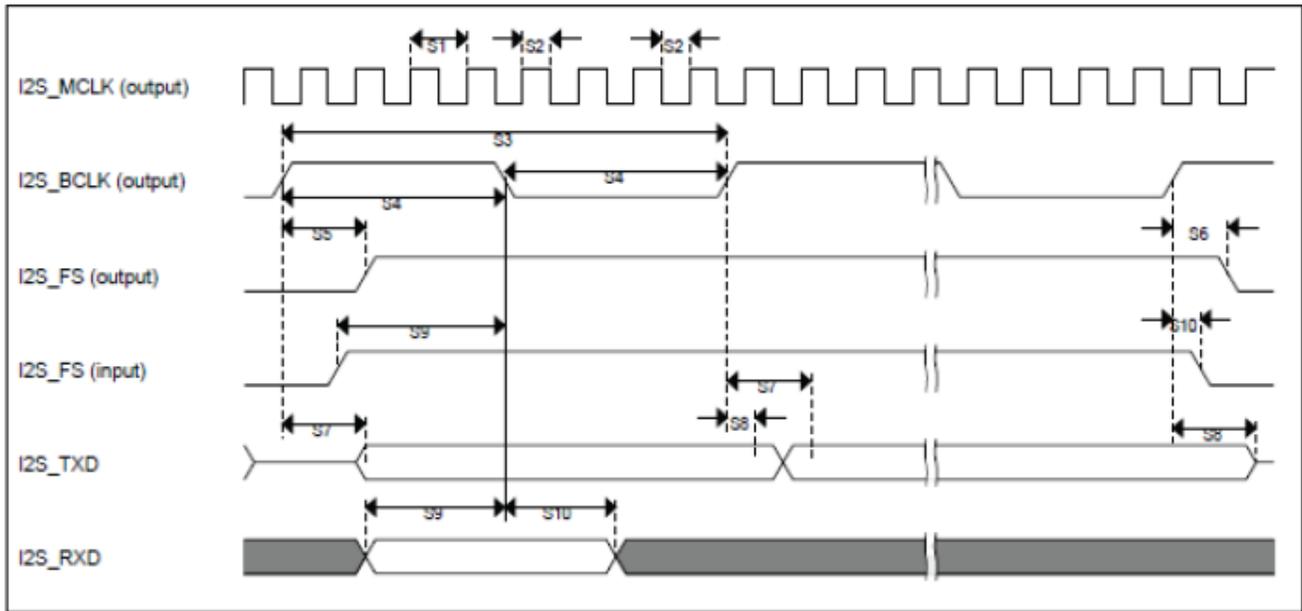


Figure 23. Master mode SAI Timing

Table 44. Slave mode SAI Timing

No	Parameter	Value		Unit
		Min	Max	
	Operating Voltage	2.7	3.6	V
S11	SAI_BCLK cycle time (input)	80	-	ns
S12	SAI_BCLK pulse width high/low (input)	45%	55%	BCLK period
S13	SAI_FS input setup before SAI_BCLK	10	-	ns
S14	SAI_FS input hold after SAI_BCLK	2	-	ns

Table continues on the next page...

Table 45. JTAG pin AC electrical characteristics ¹ (continued)

#	Symbol	Characteristic	Min	Max	Unit
12	t_{BSDVZ}	TCK Falling Edge to Output Valid out of High Impedance	—	600	ns
13	t_{BSDHZ}	TCK Falling Edge to Output High Impedance	—	600	ns
14	t_{BSDST}	Boundary Scan Input Valid to TCK Rising Edge	15	—	ns
15	t_{BSDHT}	TCK Rising Edge to Boundary Scan Input Invalid	15	—	ns

1. These specifications apply to JTAG boundary scan only.
2. This timing applies to TDI, TDO, TMS pins, however, actual frequency is limited by pad type for EXTEST instructions. Refer to pad specification for allowed transition frequency
3. Timing includes TCK pad delay, clock tree delay, logic delay and TDO output pad delay.
4. Applies to all pins, limited by pad slew rate. Refer to IO delay and transition specification and add 20 ns for JTAG delay.

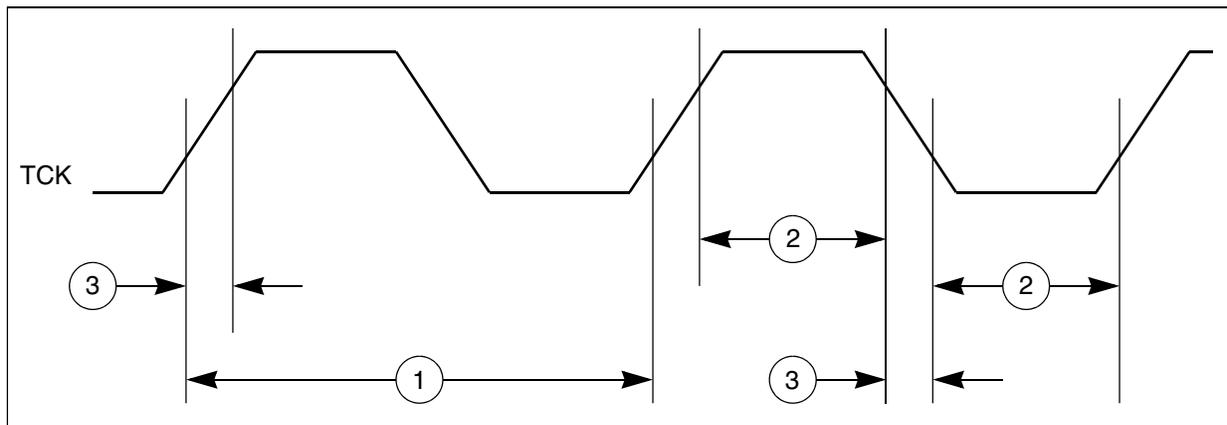


Figure 25. JTAG test clock input timing

6.5.4 External interrupt timing (IRQ pin)

Table 48. External interrupt timing specifications

No.	Symbol	Parameter	Conditions	Min	Max	Unit
1	t_{IPWL}	IRQ pulse width low	—	3	—	t_{CYC}
2	t_{IPWH}	IRQ pulse width high	—	3	—	t_{CYC}
3	t_{ICYC}	IRQ edge to edge time	—	6	—	t_{CYC}

These values applies when IRQ pins are configured for rising edge or falling edge events, but not both.

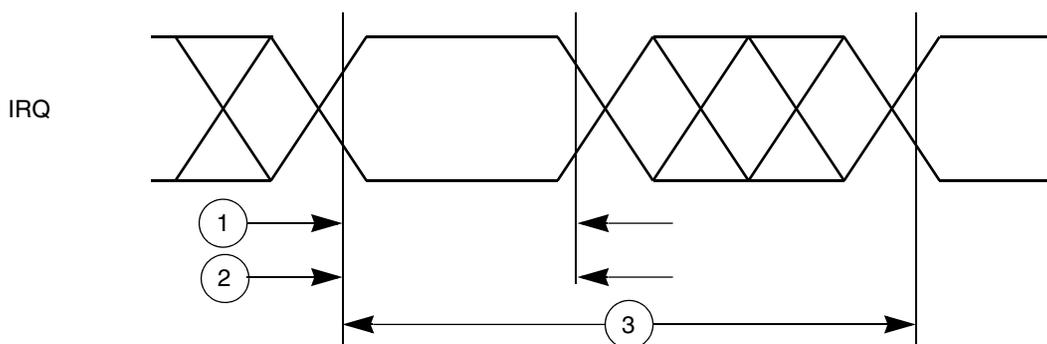


Figure 31. External interrupt timing

7 Thermal attributes

7.1 Thermal attributes

Board type	Symbol	Description	176LQFP	Unit	Notes
Single-layer (1s)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	50.7	$^{\circ}\text{C}/\text{W}$	11, 22
Four-layer (2s2p)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	24.2	$^{\circ}\text{C}/\text{W}$	1, 2, 33
Single-layer (1s)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	38.1	$^{\circ}\text{C}/\text{W}$	1, 3

Table continues on the next page...

Pinouts

Package	NXP Document Number
176-pin LQFP-EP	98ASA00698D
256 MAPBGA	98ASA00346D
324 MAPBGA	98ASA10582D

9 Pinouts

9.1 Package pinouts and signal descriptions

For package pinouts and signal descriptions, refer to the Reference Manual.

10 Reset sequence

10.1 Reset sequence

This section describes different reset sequences and details the duration for which the device remains in reset condition in each of those conditions.

10.1.1 Reset sequence duration

[Table 49](#) specifies the reset sequence duration for the five different reset sequences described in [Reset sequence description](#).

Table 49. RESET sequences

No.	Symbol	Parameter	T _{Reset}			Unit
			Min	Typ 1,1	Max	
1	T _{DRB}	Destructive Reset Sequence, BIST enabled	6.2	7.3	-	ms
2	T _{DR}	Destructive Reset Sequence, BIST disabled	110	182	-	us
3	T _{ERLB}	External Reset Sequence Long, Unsecure Boot	6.2	7.3	-	ms
4	T _{FRL}	Functional Reset Sequence Long, Unsecure Boot	110	182	-	us
5	T _{FRS}	Functional Reset Sequence Short, Unsecure Boot	7	9	-	us

1. The Typ value is applicable only if the reset sequence duration is not prolonged by an extended assertion of RESET_B by an external reset generator.

Table 51. Revision History (continued)

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"> • In section: Voltage monitor electrical characteristics <ul style="list-style-type: none"> • Updated description for Low Voltage detector block. • Added note, BCP56, MCP68 and MJD31 are guaranteed ballasts. • In table: Voltage regulator electrical specifications <ul style="list-style-type: none"> • Added footnote, Ceramic X7R or X5R type with capacitance-temperature characteristics +/-15% of -55 degC to +125degC is recommended. The tolerance +/-20% is acceptable. • Revised table, Voltage monitor electrical characteristics
		<ul style="list-style-type: none"> • In section: Supply current characteristics <ul style="list-style-type: none"> • In table: Current consumption characteristics <ul style="list-style-type: none"> • I_{DD_BODY_4}: Updated SYS_CLK to 120 MHz. • I_{DD_BODY_4}: Updated Max for T_a= 105 °C and 85 °C) • I_{dd_STOP}: Added condition for T_a= 105 °C and removed Max value for T_a= 85 °C. • I_{DD_HV_ADC_REF}: Added condition for T_a= 105 °C and 85 °C and removed Max value for T_a= 25 °C. • I_{DD_HV_FLASH}: Added condition for T_a= 105 °C and 85 °C • In table: Low Power Unit (LPU) Current consumption characteristics <ul style="list-style-type: none"> • LPU_RUN and LPU_STOP: Added condition for T_a= 105 °C and 85 °C • In table: STANDBY Current consumption characteristics <ul style="list-style-type: none"> • Added condition for T_a= 105 °C and 85 °C for all entries. • In section: I/O parameters <ul style="list-style-type: none"> • In table: Functional Pad AC Specifications @ 3.3 V Range <ul style="list-style-type: none"> • Updated values for 'pad_sr_hv (output)' • In table: DC electrical specifications @ 3.3V Range <ul style="list-style-type: none"> • Updated Min and Max values for V_{ih} and V_{il} respectively. • In table: Functional Pad AC Specifications @ 5 V Range <ul style="list-style-type: none"> • Updated values for 'pad_sr_hv (output)' • In table DC electrical specifications @ 5 V Range <ul style="list-style-type: none"> • Updated Min value for V_{hys}

Table continues on the next page...